

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/750,599	KIM, JAE-WAN	
		Examiner	Art Unit	
		Hai L. Nguyen	2816	

ISSUE CLASSIFICATION					
ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
327	552	327	553	311	
INTERNATIONAL CLASSIFICATION					
H	0	3	B	1/00	
			/		
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Hai L. Nguyen (Assistant Examiner)		9/08/2005 (Date)		TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 <i>[Signature]</i> (Primary Examiner)	
<i>[Signature]</i> (Legal Instruments Examiner)		9/14/05 (Date)		(Date)	
				Total Claims Allowed: 17	
				O.G. Print Claim(s) 1	O.G. Print Fig. 4 & 11

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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